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Application/Control No.	Applicant(s)/Patent under Reexamination
09/665,915	YAGI ET AL.
Examiner	Art Unit
Hai C. Pham	2861

SEARCHED			
Class	Subclass	Date	Examiner
347	136, 142- 144, 237, 247	2/8/2005	НР

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	·)
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EAST TEXT SEARCH	2/8/2005	НР
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